RAMAN SCATTERING AND EXCITATION SPECTROSCOPY IN CdTe/CdMnTe SUPERLATTICES

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Abstract.— We have observed oscillatory structure in the excitation spectra of CdTe/Cd_xMn_{1-x}Te superlattices. A comparison of these spectra with conventional Raman spectra shows that the structures correspond to first and higher order LO-phonons of the CdTe wells and the CdTe/Cd_xMn_{1-x}Te barriers, as well as combination of them. A strong enhancement in Resonance Raman scattering of both the CdTe and the CdMnTe phonons, at the energy of the heavy-hole exciton of the superlattice, suggests a small valence-band offset between the two materials.

INTRODUCTION

High quality superlattices (SL's) based on $Cd_xMn_{1-x}Te$ have been grown in the last years using epitaxial techniques¹⁻³. Although the optical properties of these SL's have been profusely investigated with methods such us photoluminescence (PL) and excitation spectroscopy (PLE)⁴, Raman studies are scarce⁵⁻⁷. The phonon spectra of CdTe and $Cd_xMn_{1-x}Te$ have been studied in great detail in the literature⁸, and can be used as a reference to compare new results in the SL's. Here we present a combined Resonance Raman scattering and PLE study of CdTe/CdMnTe SL's. A correlation between the Raman spectra and striking oscillatory structure in PLE is established. On the other hand, the resonant behavior of the CdTe and $Cd_xMn_{1-x}Te$ phonons indicates a small valence-band offset between the two materials.

EXPERIMENTAL RESULTS AND DISCUSSION

The samples used in our study have been grown by molecular beam epitaxy on (100)-oriented GaAs substrates. A thick (~200nm) (111)-CdTe buffer layer was followed by a CdTe/Cd $_{0.87}$ Mn $_{0.13}$ Te superlattice. Three different samples with constant well-width L_z =100A and barrier-widths L_b =100,50 and 25A were investigated. Details of the growth technique and characterization have been described in a previous publication³.

The samples were mounted on a variable temperature cryostat and kept in a He-gas atmosphere at 4.8K. An LD700 dye, pumped by a Krt-ion laser, was used to excite the samples with power densities below 1W/cm² and 5W/cm² for the PLE and the Raman experiments, respectively. The scattered light was analyzed with a 3/4m-Spex double monochromator and detected with a GaAs-cathode photomultiplier.

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Figure 1 depicts the PL (dashed line) and the PLE (solid line) spectra of a 25-periods superlattice with 100A-wide wells and barriers. A Stokes shift of 8meV between the PL and the PLE, which in GaAs/GaAlAs SL's has been attributed to well-width fluctuations? or to impurities10, is clearly observed in the figure. The PLE spectrum shows three broad structures (1.636, 1.653 and 1.695eV) together with sharp peaks, which correspond to first and higher order LO-CdTe phonons. The vertical-downward arrows show the results of a calculation, in the envelope-function approximation, for the first heavy- (h1) and light-hole (h) excitons, as well as for excitons associated with the second conduction- and valence-band levels [h2, h12, h21, where the first (second) subindex indicates conduction-(valence-) band level]. Effective masses11 me*=0.096, mh*=0.4 and mi*=0.1, free-exciton dependence on Mn concentration12, x, E(x)=1.5976+1.564x(eV), and a arbitrarily chosen 90-10% rule for the conduction- and valence-band discontinuities were used for the calculation. Taking into account the uncertainties in the parameters used for the calculation and strain effects in these lattice-mismatched superlattices12, the agreement with the experiment is satisfactory and hints to a small valence-band offset between the two materials of the SL.

Excitation spectra of a SL with 50A-wide barriers are shown in Fig.2. As the detection energy (arrow) is moved toward higher values, sharp periodic structures are resolved. These dominate completely the spectrum obtained at the high-energy tail of the PL (dashed line). The energy distance of the first two peaks to the detection energy is 21.3meV (LO) and 24.3meV (LO₂), which corresponds to the CdTe (well) and MnTe-like (in CdMnTe) LO-phonons. The additional structures, with a period between the main peaks of 21.3meV, correspond to higher order LO phonons of the CdTe wells and the CdTe/Cdo.87 Mno.12 barriers and combinations of them. Oscillatory structure in the PLE spectra of

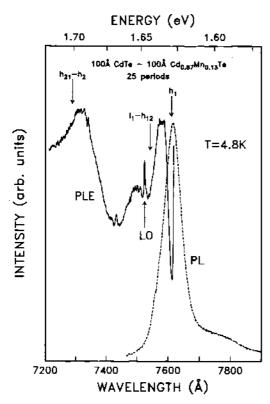
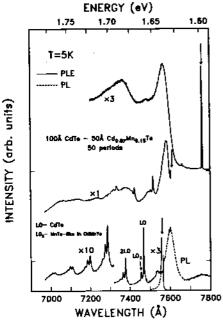
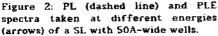


Figure 1: Photoluminescence (PL) and excitation spectra (PLE) of a CdTe/CdMnTe superlattice with 100A-wide wells.

bulk CdTe has been observed previously 13. Since phonon lines can be observed below and above the hi exciton, and a second periodicity, slightly higher than the LO frequency, is absent in our spectra, hot-exciton formation and hot-electron effects can be ruled out, leaving Resonance Raman scattering as the only mechanism responsible for observed periodic structure13. Notice that the phonon peaks are also observed in the PL spectrum, however a much higher sensitivity is obtained in the PLE spectra.

information Important about electronic excitations in semiconductor can be obtained from the resonant behavior of the Raman intensities, which occur whenever the energies of the incident (incoming channel) or scattered photons (outgoing channel) coincide with the energy of the excitation14. We have investigated first- and higher-orders Resonant Raman scattering in these SL's. Figure 3 shows the results for the first-order scattering at 4.8K for the SL with 100A-wide barriers. The spectra were recorded in the z'(x'x')z', where x' is in the plane of the layers and z' along the SL axis (the energy of the incident indicated for is spectrum). Two well-defined peaks at 172cm-1(LO-CdTe) and 196cm⁻¹(LO₂ MnTe-like), together with shoulder at 168cm-1(LO1 CdTe-like)





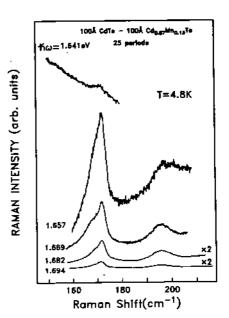
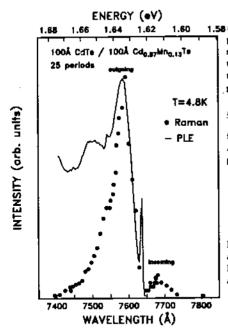


Figure 3: Raman spectra for the same sample as in Fig.1 for different laser energies.

are resolved in a broad background due to the luminescence emission of the sample. The frequencies are in good agreement with the results of Ref. 8 for a Mn concentration x=0.13. As the energy of the scattered photons approaches hi (1.636eV), a strong enhancement of the LO and LO2 phonons is observed.

The intensity of the LO phonon, uncorrected for the absorption in the sample, is plotted in Fig. 4 as a function of laser wavelength. The PLE spectrum is also shown in the figure for comparison. The Raman points have been shifted by 1LO=21.3meV towards lower energies, so that the resonance of the outgoing channel can be directly compared with the hi exciton seen in the PLE spectrum. A strong enhancement by ~2 orders of magnitude is observed at the energy of hi. A second structure at 1.615eV, 1LO phonon frequency below hi, corresponding to the incoming channel is also observed. The asymmetry in the lineshape of the outgoing resonance, as well as its stronger enhancement, have been attributed to impurity effects¹⁵. A much weaker enhancement for the li exciton can be observed in the figure; in this case the incoming and outgoing channels show a comparable behavior, in agreement with recent results of Chang et al.6

An enhancement of the LO₂ phonon at the energy of h₁ has also been observed, although in this case the resonance could not be traced below the PLE peak due to the luminescence emission of the sample and to the lower intensity of LO₂ compared to that of LO. In the energy range of 1.75-1.80eV, corresponding to the band gap of CdTe/Cdo.87Mn 0.13Te, the phonons of the barriers and the wells are again resonantly enhanced. These two facts indicate a large penetration of the hole wavefunctions into the barrier material, and therefore a a small valence-band offset between the two materials. Our results contradict recent Raman studies of Suh et al.⁷, who have found a selective resonance enhancement of the LO phonons in the barriers and in the wells. The difference could probably lie in the larger Mn concentration used in their samples (x>0.25). Furthermore, we have not observed any frequency dependence on the incident photon energy of the LO₁ and LO₂ phonons, reported for [111] CdTe/CdMnTe SL's in Ref. 7.



Finally, we should mention that, since no 1.58 appreciable shift has been measured in the LO phonon, the CdTe layers are strain-free. The strain in the CdxMni-xTe layers is more difficult to assess from our Raman measurements, since the Mn composition has been estimated only from growth parameters.

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Figure 4: Excitation spectrum of the same sample as in Fig. 1. The points show the Resonance Raman profile of the CdTe-LO phonon, shifted by a phonon frequency.

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